

ABSTRACT

SYSTEM AND METHOD FOR TESTING A DISPLAY DEVICE

A system for testing a display device is disclosed. A base has a surface with at least four holes in it. The display device has two layers and a surface. The first layer is a semiconductor substrate. The second layer is a transparent material. The surface of the display device is coupled to the surface of the base at each of the at least four apertures. The holes are positioned relative to the display device such that gravitational forces on the display device are optimally counterbalanced.